

N-Channel Enhancement Mode MOSFET

Features

- 60V/120A, $R_{DS(ON)} = 6.0 \ m\Omega \ (typ.) \ @ \ V_{GS} = 10V$
- Avalanche Rated
- Reliable and Rugged
- Lead Free and Green Devices Available (RoHS Compliant)

Pin Description



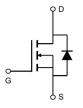


TO-220FB-3L

TO-263-2L

Applications

Power Management for Inverter Systems.



N-Channel MOSFET

Ordering and Marking Information





Package Code P: TO-220FB-3L

Date Code YYXXX WW B: TO-263-2L

Assembly Material G: Lead Free Device

Note: HUAYI lead -free products contain molding compounds/die attach materials and 100% matte tin plate Termination finish; which are fully compliant with RoHS. HUAYI lead -free products meet or exceed the lead-free requirements of IPC/JEDEC J-STD-020 for MSL classification at lead-free peak reflow temperature. HUAYI defines "Green" to mean lead-free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

HUAYI reserves the right to make changes, corrections, enhancements, modifications, and improvements to this pr-oduct and/or to this document at any time without notice.



Absolute Maximum Ratings

Symbol	Parameter		Rating	Unit		
Common	Common Ratings (T _c =25°C Unless Otherwise Noted)					
V _{DSS}	Drain-Source Voltage		60	V		
V _{GSS}	Gate-Source Voltage		±25	v		
TJ	Maximum Junction Temperature		175	°C		
T _{STG}	Storage Temperature Range		-55 to 175	°C		
Is	Diode Continuous Forward Current	T _C =25°C	120	А		
Mounted (on Large Heat Sink	•				
I _{DM}	Pulsed Drain Current *	T _C =25°C	380**	А		
	Continuous Drain Current	T _C =25°C	120			
l I _D	Continuous Diam Current	T _C =100°C	80	A		
В	Maximum Dower Discipation	T _C =25°C	188	W		
P _D	Maximum Power Dissipation	T _C =100°C	94	T vv		
$R_{\theta JC}$	Thermal Resistance-Junction to Case		0.8	°C/W		
$R_{\theta JA}$	Thermal Resistance-Junction to Ambient		62.5			
Avalanche	Avalanche Ratings					
E _{AS}	Avalanche Energy, Single Pulsed	L=0.5mH	600***	mJ		

Note: * Repetitive rating; pulse width limited by junction temperature

Electrical Characteristics $(T_c = 25^{\circ}C \text{ Unless Otherwise Noted})$

Symbol	Parameter	Test Conditions	HY1906		6	Unit	
Syllibol	Farameter	rest Conditions	Min.	Тур.	Max.	Oilit	
Static Cha	aracteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _{DS} =250μA	60	-	-	V	
	Zero Gate Voltage Drain Current	V _{DS} =60V, V _{GS} =0V	-	-	1	^	
I _{DSS}	Zero Gate Voltage Drain Current	T _J =85°C	-	-	10	μΑ	
V _{GS(th)}	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_{DS}=250\mu A$	2	3	4	V	
I _{GSS}	Gate Leakage Current	$V_{GS}=\pm 25V, V_{DS}=0V$	-	-	±100	nA	
R _{DS(ON)} *	Drain-Source On-state Resistance	V _{GS} =10V, I _{DS} =60A	1	6.0	7.5	mΩ	
Diode Cha	Diode Characteristics						
V _{SD} *	Diode Forward Voltage	I _{SD} =60A, V _{GS} =0V	-	0.8	1.2	V	
t _{rr}	Reverse Recovery Time	60 A dl /dt 100 A /	-	50	-	ns	
Q _{rr}	Reverse Recovery Charge	I _{SD} =60A, dI _{SD} /dt=100A/μs	-	95	-	nC	

^{**} Drain current is limited by junction temperature

^{***} VD=48V



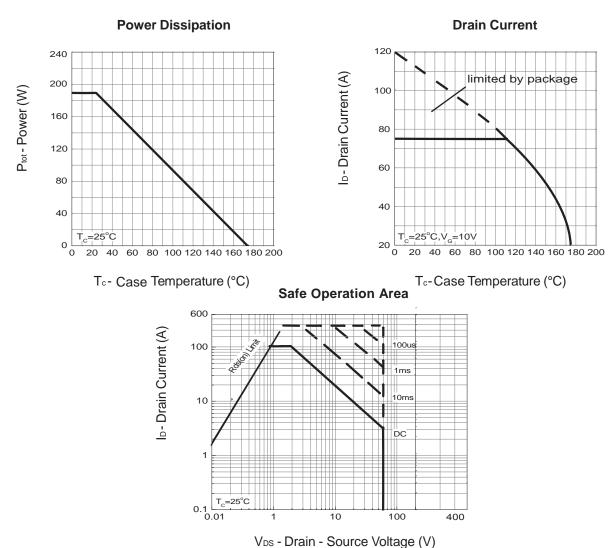
Electrical Characteristics (Cont.) $(T_c = 25^{\circ}C \text{ Unless Otherwise Noted})$

Symbol	Parameter	Test Conditions		HY1906		Unit
Symbol	Parameter	rest Conditions	Min.	Тур.	Max.	Oilit
Dynamic (Characteristics ^b					
R _G	Gate Resistance	V _{GS} =0V,V _{DS} =0V,F=1MHz	-	1.0	-	Ω
C _{iss}	Input Capacitance	$V_{GS}=0V$,	-	4577	-	
C _{oss}	Output Capacitance	V _{DS} =25V,	-	876	-	pF
C _{rss}	Reverse Transfer Capacitance	Frequency=1.0MHz	-	276	-	
t _{d(ON)}	Turn-on Delay Time		-	13	26	
Tr	Turn-on Rise Time	$V_{DD}=30V$, $R_G=6\Omega$,	-	11	20	ne
t _{d(OFF)}	Turn-off Delay Time	I_{DS} =60A, V_{GS} =10V,	-	40	66	ns
T _f	Turn-off Fall Time		-	60	95	
Gate Charge Characteristics ^b						
Q_g	Total Gate Charge		-	96	-	
Q_gs	Gate-Source Charge	V_{DS} =30V, V_{GS} =10V, V_{DS} =60A	-	21	-	nC
Q_{gd}	Gate-Drain Charge	7.03	-	23	-	

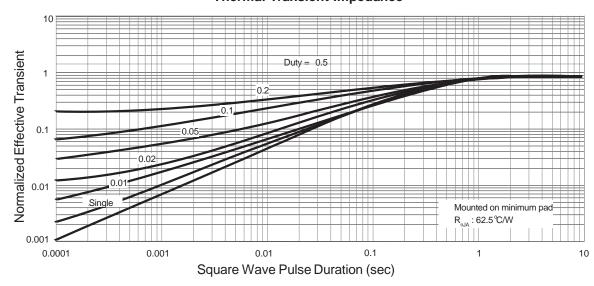
Note * : Pulse test ; pulse width \leq 300 µs, duty cycle \leq 2%.



Typical Operating Characteristics



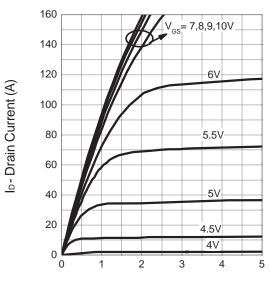
Thermal Transient Impedance





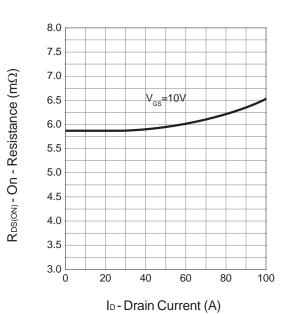
Typical Operating Characteristics (Cont.)

Output Characteristics



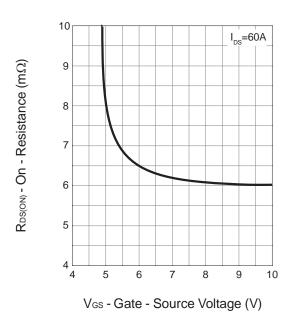
V_{DS} - Drain-Source Voltage (V)

Drain-Source On Resistance

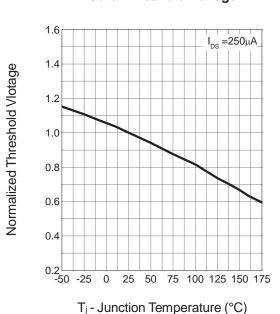


3. ()

Drain-Source On Resistance



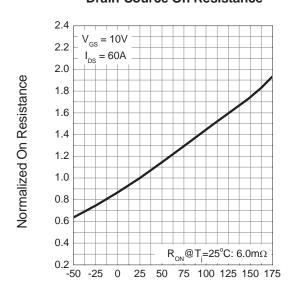
Gate Threshold Voltage





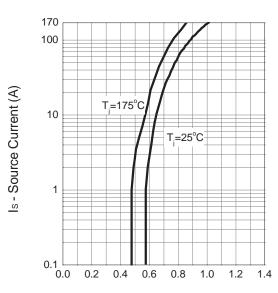
Typical Operating Characteristics (Cont.)





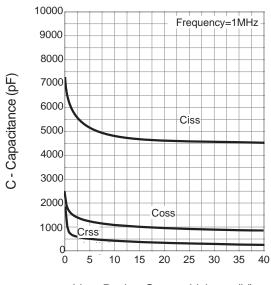
T_j- Junction Temperature (°C)

Source-Drain Diode Forward



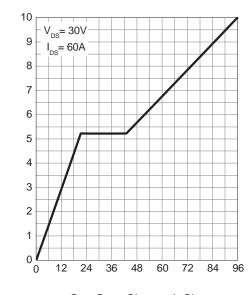
VsD - Source-Drain Voltage (V)

Capacitance



V_{DS} - Drain - Source Voltage (V)

Gate Charge

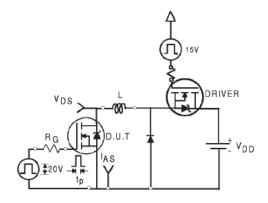


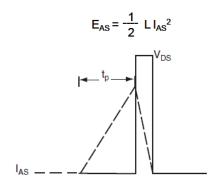
Q_G - Gate Charge (nC)

Ves - Gate-source Voltage (V)

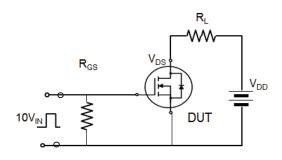


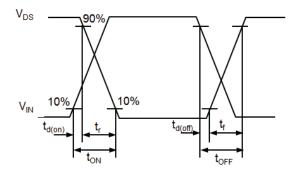
Avalanche Test Circuit



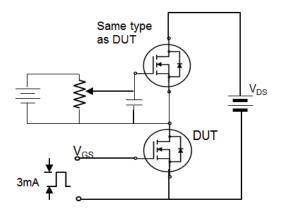


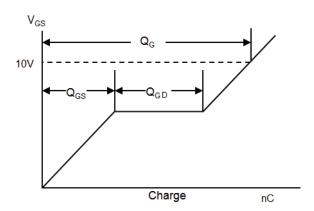
Switching Time Test Circuit





Gate Charge Test Circuit





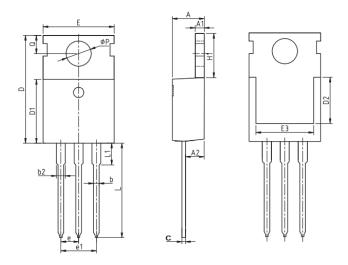


Device Per Unit

Package Type	Unit	Quantity
TO-220FB-3L	Tube	50

Package Information

TO-220FB-3L



COMMON DIMENSIONS

SYMBOL		mm	
STIVIDOL	MIN	NOM	MAX
А	4.37	4.57	4.77
A1	1.25	1.30	1.45
A2	2.20	2.40	2.60
b	0.70	0.80	0.95
b2	1.17	1.27	1.47
С	0.40	0.50	0.65
D	15.10	15.60	16.10
D1	8.80	9.10	9.40
D2	5.50	-	1
E	9.70	10.00	10.30
E3	7.00	-	-
е		2.54 BSC	
e1		5.08 BSC	
H1	6.25	6.50	6.85
L	12.75	13.50	13.80
L1	-	3.10	3.40
ФР	3.40	3.60	3.80
Q	2.60	2.80	3.00

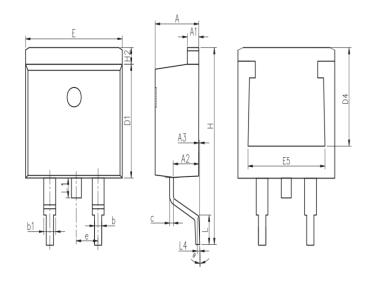


Device Per Unit

Package Type	Unit	Quantity
TO-263-2L	Tube	50

Package Information

TO-263-2L

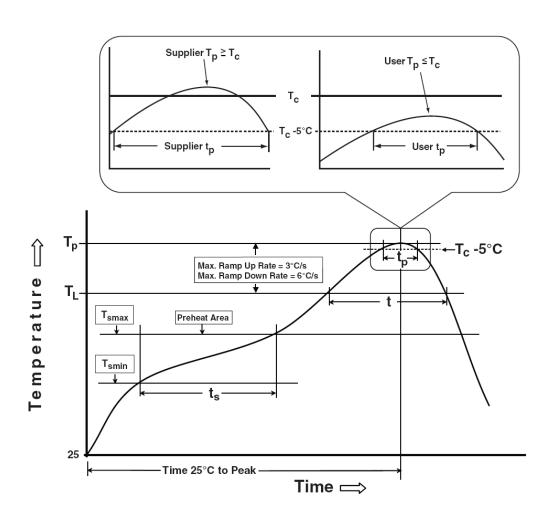


COMMON DIMENSIONS

CVMDOL		mm	
SYMBOL	MIN	NOM	MAX
А	4.37	4.57	4.77
A1	1.22	1.27	1.42
A2	2.49	2.69	2.89
A3	0	0.13	0.25
b	0.7	0.81	0.96
b1	1.17	1.27	1.47
С	0.3	0.38	0.53
D1	8.5	8.7	8.9
D4	6.6	-	-
E	9.86	10.16	10.36
E5	7.06	-	-
е		2.54 BSC	;
Н	14.7	15.1	15.5
H2	1.07	1.27	1.47
L	2	2.3	2.6
L1	1.4	1.55	1.7
L4	0.25 BSC		
θ	0°	5°	9°



Classification Profile



Classification Reflow Profiles

Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly
	100 °C 150 °C 60-120 seconds	150 °C 200 °C 60-120 seconds
Average ramp-up rate (T _{smax} to T _P)	3 °C/second max.	3°C/second max.
Liquidous temperature (T _L) Time at liquidous (t _L)	183 °C 60-150 seconds	217 °C 60-150 seconds
Peak package body Temperature $(T_p)^*$	See Classification Temp in table 1	See Classification Temp in table 2
Time (t _P)** within 5°C of the specified classification temperature (T _c)	20** seconds	30** seconds
Average ramp-down rate (T _p to T _{smax})	6 °C/second max.	6 °C/second max.
Time 25°C to peak temperature	6 minutes max.	8 minutes max.
Time 25°C to peak temperature		

Tolerance for peak profile Temperature (T_p) is defined as a supplier minimum and a user maximum. Tolerance for time at peak profile temperature (t_p) is defined as a supplier minimum and a user maximum.

HY1906P/B



Table 1. SnPb Eutectic Process – Classification Temperatures (Tc)

Package Thickness	Volume mm ³ <350	Volume mm³ ≥350
<2.5 mm	235 °C	220 °C
≥2.5 mm	220 °C	220 °C

Table 2. Pb-free Process - Classification Temperatures (Tc)

Package Thickness	Volume mm ³ <350	Volume mm ³ 350-2000	Volume mm ³ >2000
<1.6 mm	260 °C	260 °C	260 °C
1.6 mm – 2.5 mm	260 °C	250 °C	245 °C
≥2.5 mm	250 °C	245 °C	245 °C

Reliability Test Program

Test item	Method	Description
SOLDERABILITY	JESD-22, B102	5 Sec, 245°C
HTRB	JESD-22, A108	168Hrs/500Hrs/1000Hrs, Bias@125°C
PCT	JESD-22, A102	96 Hrs, 100% RH, 2atm, 121°C
TCT	JESD-22, A104	500 Cycles, -55°C~150°C

Customer Service

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